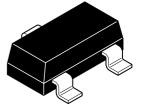


# ZXTP25020DFL 20V, SOT23, PNP low power transistor

## Summary

BV<sub>CEO</sub> > -20V BV<sub>ECO</sub> > -4V I<sub>C(cont)</sub> = 1.5A V<sub>CE(sat)</sub> < 85 mV @ 1A R<sub>CE(sat)</sub> = 54mΩ P<sub>D</sub> = 350mW



Complementary part number ZXTN25020DFL

## Description

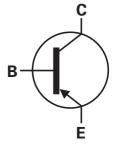
Advanced process capability has been used to achieve high current gain hold up making this device ideal for applications requiring high pulse currents.

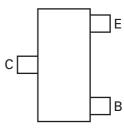
### Features

- High peak current
- Low saturation voltage

## Applications

- DC-DC converters
- MOSFET and IGBT gate driving





Pinout - top view

## Ordering information

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXTP25020DFLTA	7	8	3000

## **Device marking**

1F2

## Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-base voltage	V <sub>CBO</sub>	-25	V
Collector-emitter voltage (forward blocking)	V <sub>CEO</sub>	-20	V
Emitter-collector voltage (reverse blocking)	V <sub>ECO</sub>	-4	V
Emitter-base voltage	V <sub>EBO</sub>	-7	V
Continuous collector current	۱ <sub>C</sub>	-1.5	А
Base current	۱ <sub>B</sub>	-500	mA
Peak pulse current	I <sub>CM</sub>	-6	А
Power dissipation at T <sub>amb</sub> =25°C <sup>(a)</sup>	P <sub>D</sub>	350	mW
Linear derating factor		2.8	mW/°C
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 to 150	°C

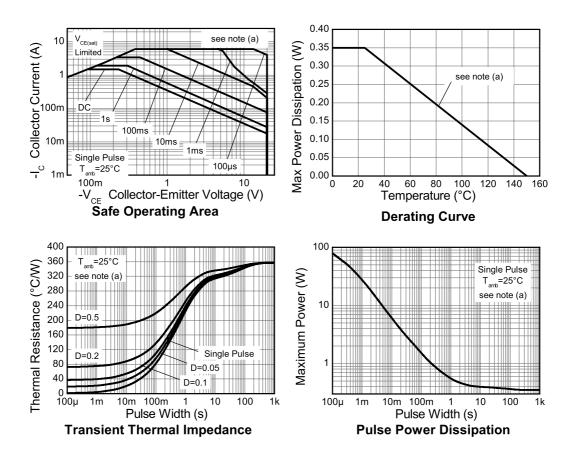
### Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient <sup>(a)</sup>	$R_{\ThetaJA}$	357	°C/W

### NOTES:

(a) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

## Characteristics



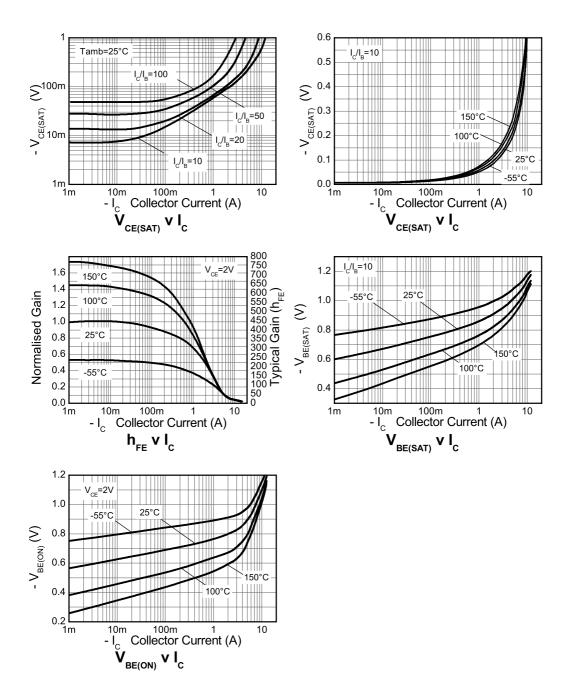
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-base breakdown voltage	BV <sub>CBO</sub>	-25	-55		V	I <sub>C</sub> = -100μA
Collector-emitter breakdown voltage (base open)	BV <sub>CEO</sub>	-20	-45		V	I <sub>C</sub> = -10mA <sup>(*)</sup>
Emitter-base breakdown voltage	BV <sub>EBO</sub>	-7	-8.3		V	I <sub>E</sub> = -100μA
Emitter-collector breakdown voltage (reverse blocking)	BV <sub>ECO</sub>	-4	-8.5		V	I <sub>E</sub> = -100uA <sup>(*)</sup>
Collector cut-off current	I <sub>CBO</sub>		<-1	-50	nA	V <sub>CB</sub> = -20V
				-20	μA	$V_{CB} = -20V, T_{amb} = 100^{\circ}C$
Emitter cut-off current	I <sub>EBO</sub>		<-1	-50	nA	V <sub>EB</sub> = -5.6V
Collector-emitter saturation	V <sub>CE(sat)</sub>		-65	-85	mV	$I_{C} = -1A, I_{B} = -100 \text{mA}^{(*)}$
voltage			-160	-225	mV	I <sub>C</sub> = -1A, I <sub>B</sub> = -10mA <sup>(*)</sup>
			150	-195	mV	I <sub>C</sub> = -1.5A, I <sub>B</sub> = -30mA <sup>(*)</sup>
			-210	-275	mV	I <sub>C</sub> = -2A, I <sub>B</sub> = -40mA <sup>(*)</sup>
			-215	260	mV	I <sub>C</sub> = -4A, I <sub>B</sub> = -400mA <sup>(*)</sup>
Base-emitter saturation voltage	V <sub>BE(sat)</sub>		-845	-950	mV	$I_{C} = -1.5A, I_{B} = -30mA^{(*)}$
Base-emitter turn-on voltage	V <sub>BE(on)</sub>		-785	-900	mV	$I_{C} = -1.5A, V_{CE} = -2V^{(*)}$
Static forward current transfer	h <sub>FE</sub>	300	450	900		$I_{C} = -10 \text{mA}, V_{CE} = -2V^{(*)}$
ratio		160	250			$I_{C} = -1.5A, V_{CE} = -2V^{(*)}$
		60	90			$I_{C} = -4A, V_{CE} = -2V^{(*)}$
			15			$I_{C} = -10A, V_{CE} = -2V^{(*)}$
Transition frequency	f <sub>T</sub>		290		MHz	I <sub>C</sub> = -50mA, V <sub>CE</sub> = -10V f = 50MHz
Output capacitance	C <sub>obo</sub>		21	30	pF	V <sub>CB</sub> = -10V, f = 1MHz <sup>(*)</sup>
Delay time	t <sub>(d)</sub>		14.2			V <sub>CC</sub> = -10V. I <sub>C</sub> = -1A, I <sub>B1</sub>
Rise time	t <sub>(r)</sub>		16.3			= I <sub>B2</sub> = -50mA.
Storage time	t <sub>(s)</sub>		186			1
Fall time	t <sub>(f)</sub>		32.7			

# Electrical characteristics (at $T_{amb} = 25^{\circ}C$ unless otherwise stated)

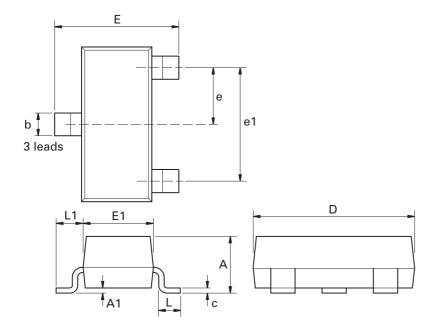
### NOTES:

(\*) Measured under pulsed conditions. Pulse width  ${\leq}300\mu s$  , duty cycle  ${\leq}2\%.$ 

## **Typical characteristics**



## Package outline - SOT23



Dim.	Millin	neters	Inc	hes	Dim.	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Max.	Max.
А	-	1.12	-	0.044	e1	1.90	NOM	0.075	NOM
A1	0.01	0.10	0.0004	0.004	E	2.10	2.64	0.083	0.104
b	0.30	0.50	0.012	0.020	E1	1.20	1.40	0.047	0.055
С	0.085	0.120	0.003	0.008	L	0.25	0.62	0.018	0.024
D	2.80	3.04	0.110	0.120	L1	0.45	0.62	0.018	0.024
е	0.95	NOM	0.0375	5 NOM	-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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